

Dual N-Channel Power MOSFET

40V, 38A, $15m\Omega$

FEATURES

- Low R_{DS(ON)} to minimize conductive losses
- Low gate charge for fast power switching
- 100% UIS and R_a tested
- RoHS Compliant
- Halogen-free according to IEC 61249-2-21

	_	_				~.	_	NIC
Α	μ	r	LI	G	А		U	NS

- BLDC Motor Control
- Battery Power Management
- DC-DC Converter
- Secondary Synchronous Rectification

KEY PERFORMANCE PARAMETERS				
PARAM	IETER	VALUE	UNIT	
V_D	S	40	V	
_ , ,	$V_{GS} = 10V$	15	•	
$R_{DS(on)}$ (max)	$V_{GS} = 7V$	28.6	mΩ	
Q	9	18	nC	



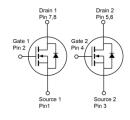




PDFN56 Dual







Note: MSL 1 (Moisture Sensitivity Level) per J-STD-020

ABSOLUTE MAXIMUM RA PARAMETER	TA-25 O din	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current (Note 1)		38	_		
Continuous Drain Current	$T_A = 25^{\circ}C$	l _D	8	Α	
Pulsed Drain Current	I _{DM}	152	Α		
Single Pulse Avalanche Current (Not	I _{AS}	15	А		
Single Pulse Avalanche Energy (Note	E _{AS}	34	mJ		
Total Dawer Dissipation	$T_C = 25^{\circ}C$	0	40	١٨/	
Total Power Dissipation	$T_{C} = 125^{\circ}C$	P_{D}	8	W	
Total Dawer Dissipation	T _A = 25°C	Б	2	10/	
Total Power Dissipation	T _A = 125°C	P_{D}	0.4	W	
Operating Junction and Storage Te	T _J , T _{STG}	- 55 to +150	°C		

THERMAL PERFORMANCE					
PARAMETER	SYMBOL	MAXIMUM	UNIT		
Junction to Case Thermal Resistance	R _{eJC}	3.1	°C/W		
Junction to Ambient Thermal Resistance	$R_{\Theta JA}$	61	°C/W		

Thermal Performance Note: $R_{\Theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\Theta JC}$ is guaranteed by design while $R_{\Theta CA}$ is determined by the user's board design. The $R_{\Theta JA}$ limit presented here is based on mounting on a 1 in² pad of 2 oz copper.



ELECTRICAL SPECIFICATIONS (T _A = 25°C unless otherwise noted)						
PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV _{DSS}	40			V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	$V_{GS(TH)}$	2	3	4	V
Gate-Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	I _{GSS}			±100	nA
	$V_{GS} = 0V, V_{DS} = 40V$				1	
Drain-Source Leakage Current	$V_{GS} = 0V, V_{DS} = 40V$ $T_{J} = 125^{\circ}C$	I _{DSS}			100	μA
Drain-Source On-State Resistance	$V_{GS} = 10V, I_D = 8A$	Б		11	15	mΩ
(Note 3)	$V_{GS} = 7V$, $I_D = 6A$	R _{DS(on)}		15	28.6	
Forward Transconductance (Note 3)	$V_{DS} = 10V, I_{D} = 8A$	g _{fs}		32		S
Dynamic (Note 4)						
Total Gate Charge	$V_{GS} = 10V, V_{DS} = 20V,$ $I_{D} = 8A$	Q_g		18		
Total Gate Charge		Q_g		13		nC
Gate-Source Charge	$V_{GS} = 7V, V_{DS} = 20V,$	Q_{gs}		6		-
Gate-Drain Charge	$I_D = 6A$	Q_{gd}		4		
Input Capacitance		C _{iss}		1132		pF
Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V$	C _{oss}		110		
Reverse Transfer Capacitance	f = 1.0MHz	C _{rss}		51		
Gate Resistance	f = 1.0MHz	R_g	0.6	2.1	4.2	Ω
Switching (Note 4)						
Turn-On Delay Time		t _{d(on)}		6		
Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 20V,$ $I_D = 8A, R_G = 2\Omega$	t _r		7		
Turn-Off Delay Time		t _{d(off)}		12		ns
Turn-Off Fall Time		t _f		3		
Source-Drain Diode						
Forward Voltage (Note 3)	$V_{GS} = 0V, I_{S} = 8A$	V _{SD}			1.2	V
Reverse Recovery Time	I _S = 8A,	t _{rr}		14		ns
Reverse Recovery Charge	dl/dt = 100A/µs	Q _{rr}		7		nC

Notes:

- 1. Silicon limited current only.
- 2. L = 0.3mH, $V_{GS} = 10$ V, $V_{DD} = 25$ V, $R_G = 25\Omega$, $I_{AS} = 15$ A, Starting $T_J = 25$ °C
- 3. Pulse test: Pulse Width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching time is essentially independent of operating temperature.

ORDERING INFORMATION

ORDERING CODE	PACKAGE	PACKING
TSM150NB04DCR RLG	PDFN56 Dual	2,500pcs / 13" Reel



CHARACTERISTICS CURVES

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

0.4

-75

0

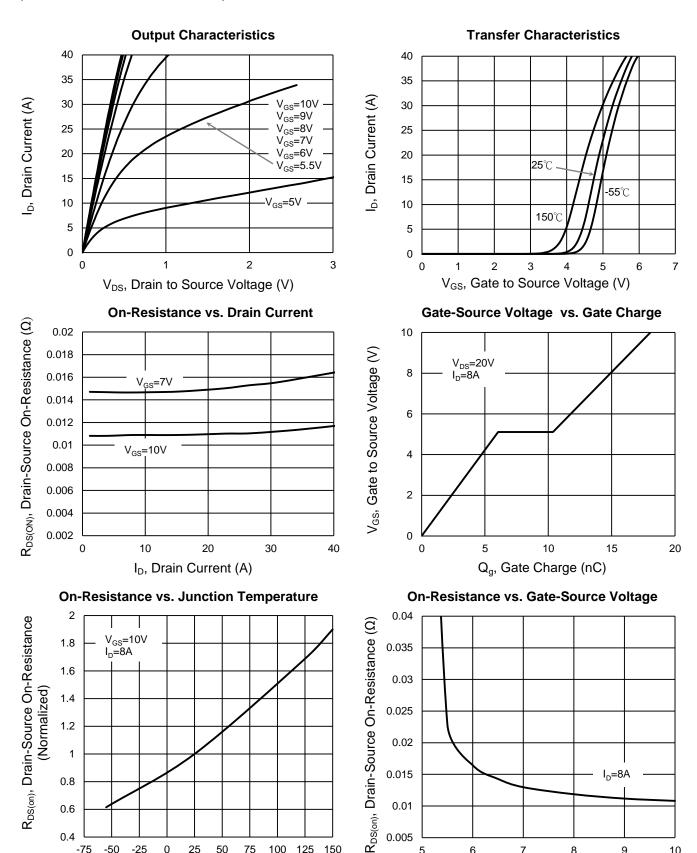
25

T_J, Junction Temperature (°C)

50

75

100



0.005

3

6

125 150

Version: A1908

V_{GS}, Gate to Source Voltage (V)

7

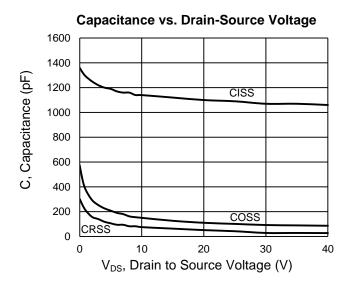
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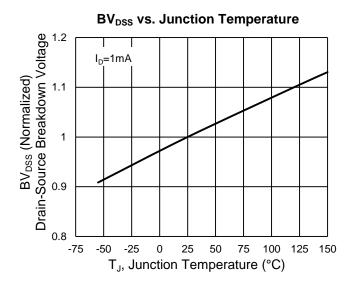
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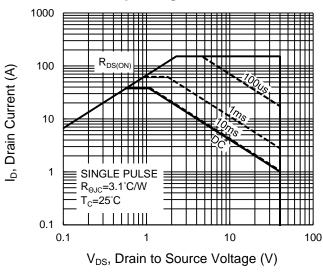
CHARACTERISTICS CURVES

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$



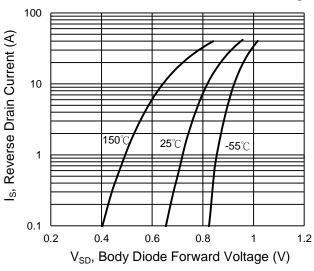


Maximum Safe Operating Area, Junction-to-Case

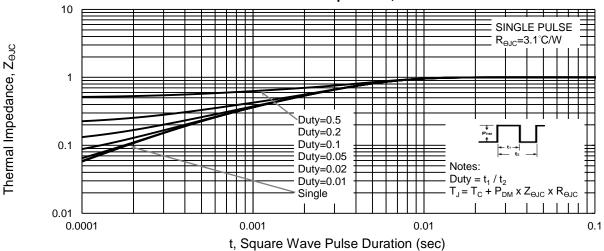


Normalized Effective Transient

Source-Drain Diode Forward Current vs. Voltage





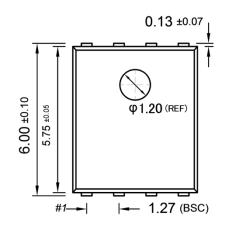


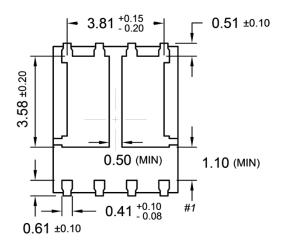
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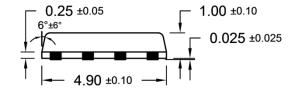


PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

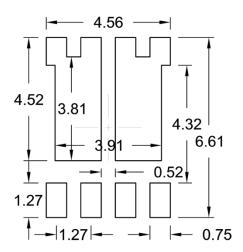
PDFN56 Dual







SUGGESTED PAD LAYOUT (Unit: Millimeters)



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MARKING DIAGRAM



Y = Year Code

WW = Week Code (01~52)

L = Lot Code (1~9,A~Z)

F = Factory Code



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